



18 V, Precision, 725 μ A, 4 MHz CMOS RRIO Operational Amplifier

Preliminary Technical Data

ADA4661-2

FEATURES

Low power at high voltage (18 V): 725 μ A maximum

Low offset voltage:

100 μ V maximum at $V_{CM}/2$

350 μ V maximum over entire common mode range

Low input bias current: 10 pA maximum

Gain bandwidth product: xxx kHz at $A_v = 100$ typical

Unity-gain crossover: 4.5MHz typical

–3 dB closed-loop bandwidth: xxx MHz typical

Single-supply operation: 3 V to 18 V

Dual-supply operation: ± 1.5 V to ± 9 V

Unity-gain stable

Excellent electromagnetic interference immunity

APPLICATIONS

Portable operating systems

Current monitors

4 mA to 20 mA loop drivers

Buffer/level shifting

Multipole filters

Remote/wireless sensors

Low power transimpedance amplifiers

PIN CONNECTION DIAGRAMS

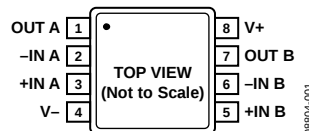


Figure 1. Pin Configuration, 8-Lead MSOP & LFCSP (RM & CP Suffix)

Table 1. Low power Op Amps (< xxx μ A)

Supply Voltage	5 V	12 V to 16 V	36 V
Single			
Dual			
Quad			

GENERAL DESCRIPTION

The ADA4661-2 is a dual, low power, precision, rail-to-rail input/output amplifier optimized for 4 MHz, low power and wide operating supply voltage range applications.

The ADA4661-2 performance is guaranteed at 3.0 V, 10 V, and 18 V power supply voltages. It is an excellent selection for applications using single ended supplies of 3.3V, 5V, 10V, 12V and 15V and dual supplies of ± 2.5 V, ± 3.3 V and ± 5 V. It uses Analog Devices, Inc., patented DigiTrim[®] trimming technique, which achieves low offset voltage. The ADA4661-2 also has high immunity to electromagnetic interference.

The ADA4661-2 is specified over the extended industrial temperature range (-40°C to $+125^{\circ}\text{C}$) and is available in an 8-lead MSOP and LFCSP (3mm x 3mm) packages.

Rev. PrA

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SPECIFICATIONS

ELECTRICAL CHARACTERISTICS—3.0 V OPERATION

$V_{SY} = 3.0\text{ V}$, $V_{CM} = V_{SY}/2$, $T_A = 25^\circ\text{C}$, unless otherwise specified.

Table 2.

Parameter	Symbol	Test Conditions/Comments	Min	Typ	Max	Unit
INPUT CHARACTERISTICS						
Offset Voltage	V_{OS}	$V_{CM} = V_{SY}/2$ $V_{CM} = 0\text{ V to } 3.0\text{ V}$ $V_{CM} = 0\text{ V to } 3.0\text{ V}; -40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$			<100 350 1	μV μV mV
Offset Voltage Drift	$\Delta V_{OS}/\Delta T$			TBD	3	$\mu\text{V}/^\circ\text{C}$
Input Bias Current	I_B	$-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$		TBD	3	pA
Input Offset Current	I_{OS}	$-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$			TBD 3 TBD	nA pA pA
Input Voltage Range			0		3	V
Common-Mode Rejection Ratio	CMRR	$V_{CM} = 0\text{ V to } 3.0\text{ V}$ $V_{CM} = 0\text{ V to } 3.0\text{ V}; -40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	90 TBD	120		dB dB
Large Signal Voltage Gain	A_{VO}	$R_L = 10\text{ k}\Omega$, $V_O = 0.5\text{ V to } 2.5\text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	TBD TBD	130		dB dB
Input Resistance	R_{IN}			>TBD		$\text{G}\Omega$
Input Capacitance, Differential Mode	C_{INDM}			TBD		pF
Input Capacitance, Common Mode	C_{INCM}			TBD		pF
OUTPUT CHARACTERISTICS						
Output Voltage High	V_{OH}	$I_L = 1\text{ mA to } V^{-1}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	2.98 TBD	TBD		V V
Output Voltage Low	V_{OL}	$I_L = 10\text{ mA to } V^{-1}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ $I_L = 1\text{ mA to } V^{+1}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ $I_L = 10\text{ mA to } V^{+1}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	2.8 TBD	TBD	20 200	V mV mV mV
Short-Circuit Current	I_{SC}				TBD	mV
Closed-Loop Output Impedance	Z_{OUT}	$f = \text{TBD kHz}$, $A_V = 1$		± 20 TBD		mA Ω
POWER SUPPLY						
Power Supply Rejection Ratio	PSRR	$V_{SY} = 3.0\text{ V to } 18\text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	130 TBD	TBD		dB dB
Supply Current per Amplifier	I_{SY}	$I_O = 0\text{ mA}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$		TBD	725 TBD	μA μA
DYNAMIC PERFORMANCE						
Slew Rate	SR	$R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_V = 1$		2.2		$\text{V}/\mu\text{s}$
Gain Bandwidth Product	GBP	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_{VO} = 100$		TBD		kHz
Unity-Gain Crossover	UGC	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_{VO} = 1$		4.5		MHz
–3 dB Closed-Loop Bandwidth	$f_{-3\text{ dB}}$	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_V = 1$		TBD		kHz
Settling Time to 0.1%	t_s	$V_{IN} = 1\text{ V step}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$		TBD		μs
Phase Margin	Φ_M	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_{VO} = 1$		TBD		Degrees
Channel Separation	CS	$f = 10\text{ kHz}$, $R_L = 10\text{ k}\Omega$		TBD		dB
EMI Rejection Ratio of +IN x	EMIRR	$V_{IN} = 100\text{ mV}_{PEAK}$; $f = 400\text{ MHz}$, 900 MHz , 1800 MHz , 2400 MHz		TBD		dB
NOISE PERFORMANCE						
Total Harmonic Distortion + Noise BW = 80 kHz	THD+N	$G = +1$, $f = 20\text{ Hz to } 20\text{ kHz}$, $V_{IN} = \text{TBD @ } X\text{ kHz}$		TBD		%

Parameter	Symbol	Test Conditions/Comments	Min	Typ	Max	Unit
BW = 500 kHz				TBD		%
Peak-to-Peak Noise	e_n p-p	$f = 0.1 \text{ Hz to } 10 \text{ Hz}$		TBD		$\mu\text{V p-p}$
Voltage Noise Density	e_n	$f = 1 \text{ kHz}$		18		$\text{nV}/\sqrt{\text{Hz}}$
		$f = 10 \text{ kHz}$		12		$\text{nV}/\sqrt{\text{Hz}}$
Current Noise Density	i_n	$f = 1 \text{ kHz}$		<TBD		$\text{pA}/\sqrt{\text{Hz}}$

ELECTRICAL CHARACTERISTICS – 10 V OPERATION

$V_{SY} = 10\text{ V}$, $V_{CM} = V_{SY}/2\text{ V}$, $T_A = 25^\circ\text{C}$, unless otherwise specified

Table 2.

Parameter	Symbol	Test Conditions/Comments	Min	Typ	Max	Unit
INPUT CHARACTERISTICS						
Offset Voltage	V_{OS}	$V_{CM} = V_{SY}/2$ $V_{CM} = 0\text{ V to }10\text{ V}$ $V_{CM} = 0\text{ V to }10\text{ V}; -40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$			<100 350 1	μV μV mV
Offset Voltage Drift	$\Delta V_{OS}/\Delta T$			TBD	3	$\mu\text{V}/^\circ\text{C}$
Input Bias Current	I_B	$-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$		TBD	3	pA
Input Offset Current	I_{OS}	$-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$			TBD 3 TBD	nA pA pA
Input Voltage Range			0		10	V
Common-Mode Rejection Ratio	CMRR	$V_{CM} = 0\text{ V to }10\text{ V}$ $V_{CM} = 0\text{ V to }10\text{ V}; -40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	90 TBD	120		dB dB
Large Signal Voltage Gain	A_{VO}	$R_L = 10\text{ k}\Omega$, $V_O = 0.5\text{ V to }9.5\text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	TBD TBD	130		dB dB
Input Resistance	R_{IN}			TBD		$\text{G}\Omega$
Input Capacitance, Differential Mode	C_{INDM}			TBD		pF
Input Capacitance, Common Mode	C_{INCM}			TBD		pF
OUTPUT CHARACTERISTICS						
Output Voltage High	V_{OH}	$I_L = 1\text{ mA to }V^-$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	4.98 TBD	TBD		V V
Output Voltage Low	V_{OL}	$I_L = 10\text{ mA to }V^-$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ $I_L = 1\text{ mA to }V^+$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ $I_L = 10\text{ mA to }V^+$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	4.8 TBD	TBD		V V
Short-Circuit Current	I_{SC}			TBD	20	mV
Closed-Loop Output Impedance	Z_{OUT}	$f = \text{TBD kHz}$, $A_V = 1$		TBD	200	mV mV mV
POWER SUPPLY						
Power Supply Rejection Ratio	PSRR	$V_{SY} = 3.0\text{ V to }18\text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	130 TBD	TBD		dB dB
Supply Current per Amplifier	I_{SY}	$I_O = 0\text{ mA}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$		TBD	725 TBD	μA μA
DYNAMIC PERFORMANCE						
Slew Rate	SR	$R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_V = 1$		2.2		$\text{V}/\mu\text{s}$
Gain Bandwidth Product	GBP	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_{VO} = 100$		TBD		kHz
Unity-Gain Crossover	UGC	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_{VO} = 1$		4.5		MHz
–3 dB Closed-Loop Bandwidth	$f_{-3\text{ dB}}$	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_V = 1$		TBD		kHz
Settling Time to 0.1%	t_s	$V_{IN} = 1\text{ V step}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$		TBD		μs
Phase Margin	Φ_M	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_{VO} = 1$		TBD		Degrees
Channel Separation	CS	$f = 10\text{ kHz}$, $R_L = 10\text{ k}\Omega$		TBD		dB
EMI Rejection Ratio of +IN x	EMIRR	$V_{IN} = 100\text{ mV}_{PEAK}$, $f = 400\text{ MHz}$, 900 MHz , 1800 MHz , 2400 MHz		TBD		dB
NOISE PERFORMANCE						
Total Harmonic Distortion + Noise	THD+N	$G = +1$, $f = 20\text{ Hz to }20\text{ kHz}$, $V_{IN} = \text{TBD @ X kHz}$		TBD		%
BW = 80 kHz				TBD		%
BW = 500 kHz				TBD		%
Peak-to-Peak Noise	$e_n\text{ p-p}$	$f = 0.1\text{ Hz to }10\text{ Hz}$		TBD		$\mu\text{V p-p}$

Parameter	Symbol	Test Conditions/Comments	Min	Typ	Max	Unit
Voltage Noise Density	e_n	f = 1 kHz		18		nV/ $\sqrt{\text{Hz}}$
		f = 10 kHz		12		nV/ $\sqrt{\text{Hz}}$
Current Noise Density	i_n	f = 1 kHz		TBD		pA/ $\sqrt{\text{Hz}}$

ELECTRICAL CHARACTERISTICS – 18V OPERATION

$V_{SY} = 18\text{ V}$, $V_{CM} = V_{SY}/2\text{ V}$, $T_A = 25^\circ\text{C}$, unless otherwise specified

Table 4.

Parameter	Symbol	Test Conditions/Comments	Min	Typ	Max	Unit
INPUT CHARACTERISTICS						
Offset Voltage	V_{OS}	$V_{CM} = V_{SY}/2$ $V_{CM} = 0\text{ V to }18\text{ V}$ $V_{CM} = 0\text{ V to }18\text{ V}; -40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$			<100 350 1	μV μV mV
Offset Voltage Drift	$\Delta V_{OS}/\Delta T$			TBD	3	$\mu\text{V}/^\circ\text{C}$
Input Bias Current	I_B	$-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$		TBD	3	pA
Input Offset Current	I_{OS}	$-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$			TBD 3	nA pA
Input Voltage Range			0		18	V
Common-Mode Rejection Ratio	CMRR	$V_{CM} = 0\text{ V to }18\text{ V}$ $V_{CM} = 0\text{ V to }18\text{ V}; -40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	90 TBD	120		dB dB
Large Signal Voltage Gain	A_{VO}	$R_L = 10\text{ k}\Omega$, $V_O = 0.5\text{ V to }17.5\text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	TBD TBD	130		dB dB
Input Resistance	R_{IN}			TBD		$\text{G}\Omega$
Input Capacitance, Differential Mode	C_{INDM}			TBD		pF
Input Capacitance, Common Mode	C_{INCM}			TBD		pF
OUTPUT CHARACTERISTICS						
Output Voltage High	V_{OH}	$I_L = 1\text{ mA to }V^{-1}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	2.98 TBD	TBD		V V
Output Voltage Low	V_{OL}	$I_L = 10\text{ mA to }V^{-1}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ $I_L = 1\text{ mA to }V^{+1}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ $I_L = 10\text{ mA to }V^{+1}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	2.8 TBD	TBD	20	V V mV mV
Short-Circuit Current	I_{SC}				200	mV
Closed-Loop Output Impedance	Z_{OUT}	$f = \text{TBD kHz}$, $A_V = 1$		± 20 TBD		mV mV mA Ω
POWER SUPPLY						
Power Supply Rejection Ratio	PSRR	$V_{SY} = 3.0\text{ V to }18\text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	130 TBD	TBD		dB dB
Supply Current per Amplifier	I_{SY}	$I_O = 0\text{ mA}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$		TBD	725 TBD	μA μA
DYNAMIC PERFORMANCE						
Slew Rate	SR	$R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_V = 1$		2.2		$\text{V}/\mu\text{s}$
Gain Bandwidth Product	GBP	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_{VO} = 100$		TBD		kHz
Unity-Gain Crossover	UGC	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_{VO} = 1$		4.5		MHz
–3 dB Closed-Loop Bandwidth	$f_{-3\text{ dB}}$	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_V = 1$		TBD		kHz
Settling Time to 0.1%	t_s	$V_{IN} = 1\text{ V step}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$		TBD		μs
Phase Margin	Φ_M	$V_{IN} = 10\text{ mVp-p}$, $R_L = 10\text{ k}\Omega$, $C_L = 10\text{ pF}$, $A_{VO} = 1$		TBD		Degrees
Channel Separation	CS	$f = 10\text{ kHz}$, $R_L = 10\text{ k}\Omega$		TBD		dB
EMI Rejection Ratio of +IN x	EMIRR	$V_{IN} = 100\text{ mV}_{PEAK}$, $f = 400\text{ MHz}$, 900 MHz , 1800 MHz , 2400 MHz		TBD		dB
NOISE PERFORMANCE						

¹ Load Resistance for V_{OH} and V_{OL} testing can be calculated as $V_{SY}/I_L = R_L$ and can be approximated as: $3\text{ k}\Omega$ for $I_L = 1\text{ mA}$ and $300\text{ }\Omega$ for $I_L = 10\text{ mA}$ with $V_{SY} = 3.0\text{ V}$, $10\text{ k}\Omega$ for $I_L = 1\text{ mA}$ and $1\text{ k}\Omega$ for $I_L = 10\text{ mA}$ with $V_{SY} = 10\text{ V}$, and $18\text{ k}\Omega$ for $I_L = 1\text{ mA}$ and $1.8\text{ k}\Omega$ for $I_L = 10\text{ mA}$ with $V_{SY} = 18\text{ V}$.

Parameter	Symbol	Test Conditions/Comments	Min	Typ	Max	Unit
Total Harmonic Distortion + Noise	THD+N	G= +1, f = 20 Hz to 20 kHz, V _{IN} = TBD @ X kHz				
BW = 80 kHz				TBD		%
BW = 500 kHz				TBD		%
Peak-to-Peak Noise	e _n p-p	f = 0.1 Hz to 10 Hz		TBD		μV p-p
Voltage Noise Density	e _n	f = 1 kHz		18		nV/√Hz
		f = 10 kHz		12		nV/√Hz
Current Noise Density	i _n	f = 1 kHz		TBD		pA/√Hz

ABSOLUTE MAXIMUM RATINGS

Table 3.

Parameter	Rating
Supply Voltage	20.5 V
Input Voltage	(V ₋) – 300 mV to (V ₊) + 300 mV
Input Current ¹	±10 mA
Differential Input Voltage	±V _{SY}
Output Short-Circuit Duration to GND	Indefinite
Temperature Range	
Storage	–65°C to +150°C
Operating	–40°C to +125°C
Junction	–65°C to +150°C
Lead Temperature (Soldering, 60 sec)	300°C

¹ The input pins have clamp diodes to the power supply pins. Limit the input current to 10 mA or less whenever input signals exceed the power supply rail by 0.3 V.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

THERMAL RESISTANCE

θ_{JA} is specified for the worst-case conditions, that is, a device soldered in a circuit board for surface-mount packages using a standard 4-layer JEDEC board. The exposed pad (LFCSP packages only) is soldered to the board.

Table 4. Thermal Resistance

Package Type	θ_{JA}	θ_{JC}	Unit
8-Lead MSOP (RM-8)	142	45	°C/W
8-Lead LFCSP (CP-8)	TBD	TBD	°C/W

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

NOTES